

VISHAY

Si4473DY
Vishay Siliconix

P-Channel 14-V (D-S) MOSFET

PRODUCT SUMMARY

V_{DS} (V)	$r_{DS(on)}$ (Ω)	I_D (A)
-14	0.011 @ $V_{GS} = -4.5$ V	-13
	0.016 @ $V_{GS} = -2.5$ V	-11

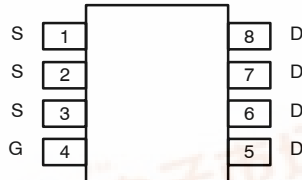
FEATURES

- TrenchFET® Power MOSFET

APPLICATION

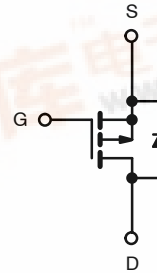
- Battery Switch for Portable Equipment

SO-8



Top View

Ordering Information: Si4473DY
Si4473DY-T1 (with Tape and Reel)
Si4473DY—E3 (Lead (Pb)-Free)
Si4473DY-T1—E3 (Lead (Pb)-Free with Tape and Reel)



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter		Symbol	10 secs	Steady State	Unit
Drain-Source Voltage		V_{DS}	-14		V
Gate-Source Voltage		V_{GS}	± 12		
Continuous Drain Current ($T_J = 150^{\circ}\text{C}$) ^a	$T_A = 25^{\circ}\text{C}$	I_D	-13	-9	A
	$T_A = 70^{\circ}\text{C}$		-10	-7	
Pulsed Drain Current		I_{DM}	-50		
continuous Source Current (Diode Conduction) ^a		I_S	-2.7	-1.36	
Maximum Power Dissipation ^a	$T_A = 25^{\circ}\text{C}$	P_D	3.0	1.5	W
	$T_A = 70^{\circ}\text{C}$		1.9	0.95	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	-55 to 150		$^{\circ}\text{C}$

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^a	R_{thJA}	33	42	$^\circ\text{C/W}$
		70	84	
Maximum Junction-to-Foot (Drain)	R_{thJF}	16	21	

Notes:
a. Surface Mounted on 1" x 1" FR4 Board.

SPECIFICATIONS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\ \mu\text{A}$	-0.6		1.5	V
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\ \text{V}, V_{GS} = \pm 12\ \text{V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -14\ \text{V}, V_{GS} = 0\ \text{V}$			-1	μA
		$V_{DS} = -14\ \text{V}, V_{GS} = 0\ \text{V}, T_J = 70^\circ\text{C}$			-10	
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} = -5\ \text{V}, V_{GS} = -4.5\ \text{V}$	-30			A
Drain-Source On-State Resistance ^a	$r_{DS(on)}$	$V_{GS} = -4.5\ \text{V}, I_D = -13\ \text{A}$		0.0088	0.011	Ω
		$V_{GS} = -2.5\ \text{V}, I_D = -11\ \text{A}$		0.013	0.016	
Forward Transconductance ^a	g_{fs}	$V_{DS} = -17\ \text{V}, I_D = -13\ \text{A}$		50		S
Diode Forward Voltage ^a	V_{SD}	$I_S = -2.7\ \text{A}, V_{GS} = 0\ \text{V}$		-0.65	-1.1	V
Dynamic^b						
Total Gate Charge	Q_g	$V_{DS} = -10\ \text{V}, V_{GS} = -4.5\ \text{V}, I_D = -13\ \text{A}$		46	70	nC
Gate-Source Charge	Q_{gs}			9		
Gate-Drain Charge	Q_{gd}			13.2		
Gate Resistance	R_g		1.5	3.2	5.3	Ω
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = -15\ \text{V}, R_L = 10\ \Omega$ $I_D \cong -1\ \text{A}, V_{GEN} = -4.5\ \text{V}, R_g = 6\ \Omega$		35	55	ns
Rise Time	t_r			45	70	
Turn-Off Delay Time	$t_{d(off)}$			160	240	
Fall Time	t_f			140	210	
Source-Drain Reverse Recovery Time	t_{rr}	$I_F = -2.1\ \text{A}, di/dt = 100\ \text{A}/\mu\text{s}$		55	80	

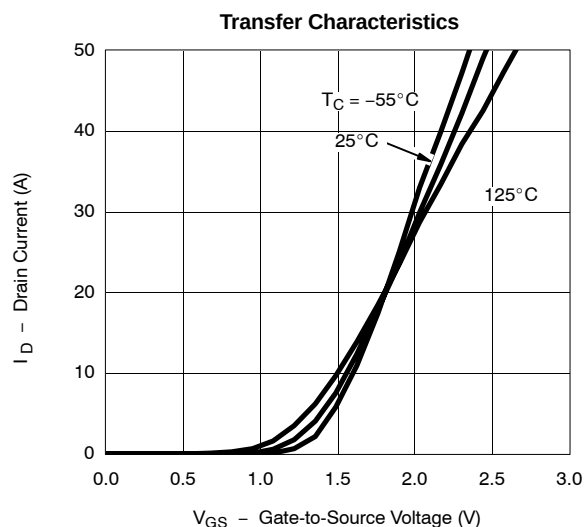
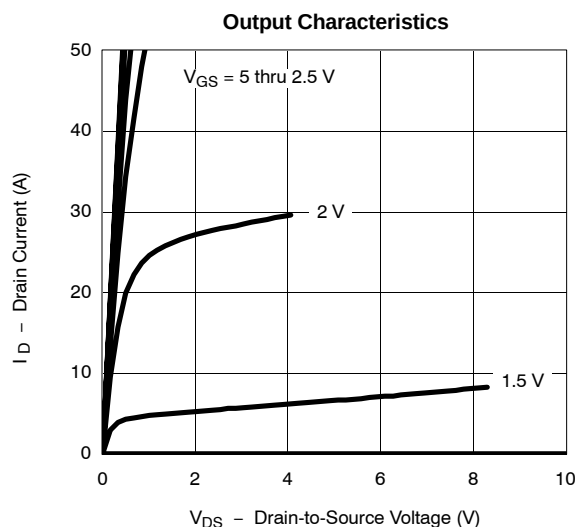
Notes

a. Pulse test; pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

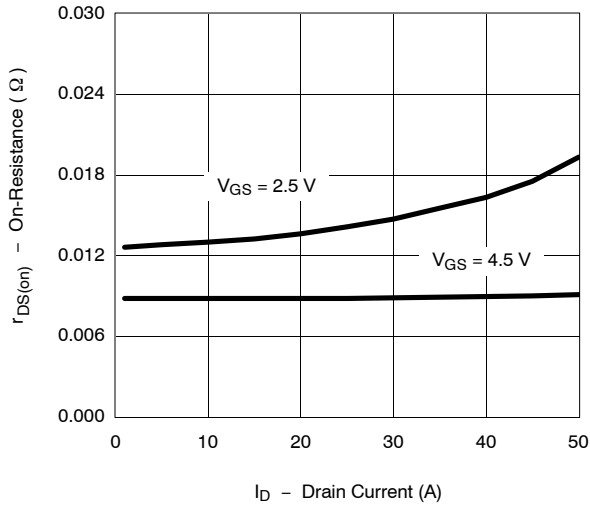
TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)



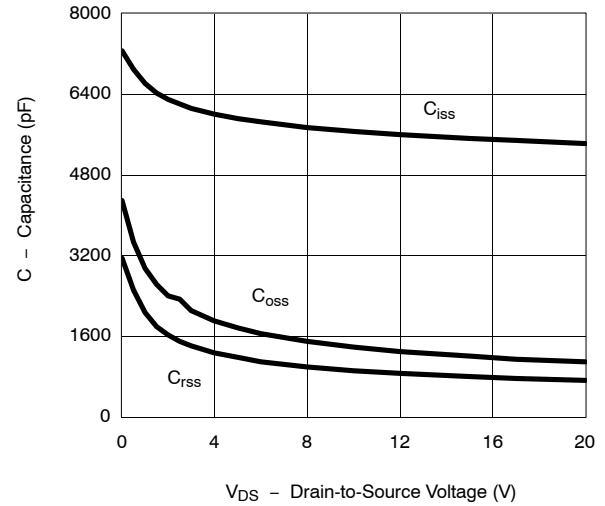


TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

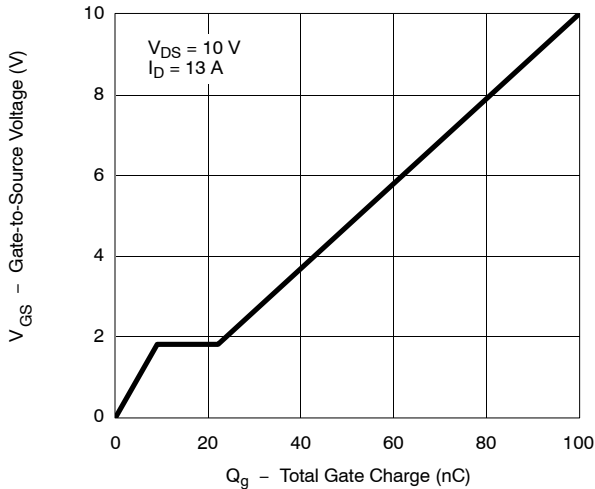
On-Resistance vs. Drain Current



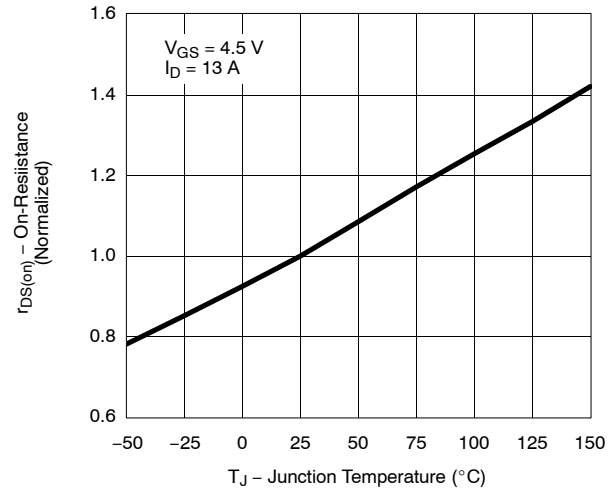
Capacitance



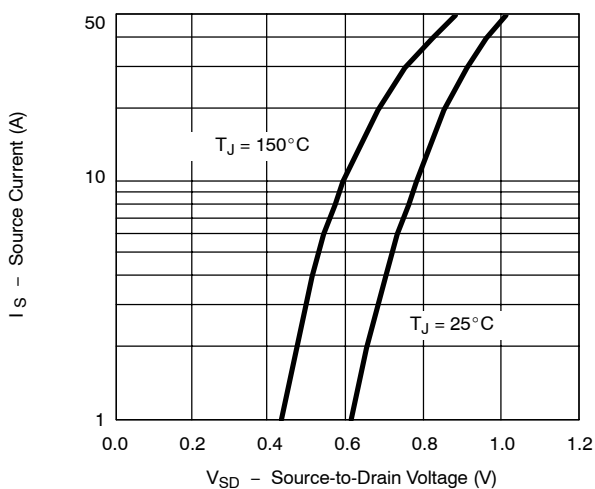
Gate Charge



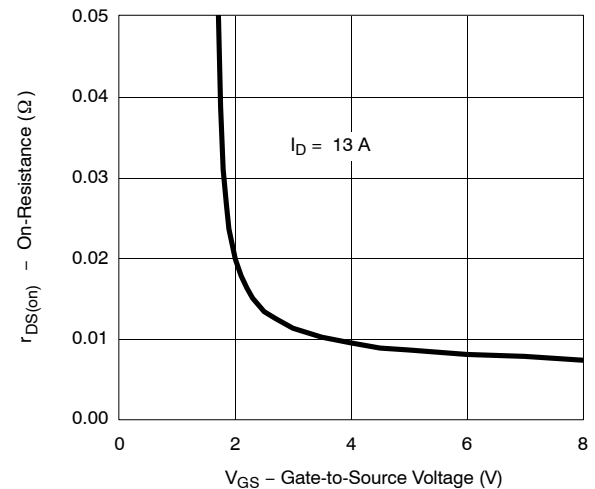
On-Resistance vs. Junction Temperature



Source-Drain Diode Forward Voltage



On-Resistance vs. Gate-to-Source Voltage



TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED)

